

Low-Cost E Series Multifunction I/O – 200 kS/s, 12-Bit, 16 Analog Inputs

6023E/6024E/6025E Families

6023E/6024E/6025E Families

6023E Family

PCI-6023E

6024E Family

PCI-6024E

6025E Family

PCI-6025E

PXI-6025E

Analog Inputs

16 single-ended, 8 differential channels
200 kS/s sampling rate
200 kS/s stream-to-disk rate
12-bit resolution

Analog Output (6024E and 6025E only)

2 channels, 12-bit resolution

Digital I/O

8 (5 V/TTL) lines (6023E and 6024E)
32 (5 V/TTL) lines (6025E)

Counter/Timers

2 up/down, 24-bit resolution

Triggering

Digital

Driver Software

NI-DAQ

Windows 2000/NT/9x
Mac OS*

*not for all hardware,
refer to page 192

Application Software

LabVIEW Measure
LabWindows/CVI BridgeVIEW
ComponentWorks Lookout
VirtualBench

Calibration Certificate Included!

(refer to page 216)



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Family	Bus	Analog Inputs	Resolution	Sampling Rate	Input Range	Analog Outputs	Resolution	Output Rate	Output Range	Digital I/O	Counter/Timers	Triggers
6023E	PCI	16 SE/8 DI	12 bits	200 kS/s	±0.05 to ±10 V	–	–	–	–	8	2, 24-bit	Digital
6024E	PCI	16 SE/8 DI	12 bits	200 kS/s	±0.05 to ±10 V	2	12 bits	10 kS/s ¹	±10 V	8	2, 24-bit	Digital
6025E	PCI, PXI/CPCI	16 SE/8 DI	12 bits	200 kS/s	±0.05 to ±10 V	2	12 bits	10 kS/s ¹	±10 V	32	2, 24-bit	Digital

¹ 10 kS/s system dependent when using the single DMA channel for analog output. 1 kS/s system dependent when using the single DMA channel for either analog input or counter/timer operations.

Table 1. 6023E/6024E/6025E Families Channel, Speed, and Resolution Specifications (refer to page 304 for more detailed specifications)

Overview

The 6023E, 6024E, and 6025E are our lowest cost families of devices that use E Series technology to deliver high performance and reliable data acquisition capabilities in a wide range of applications. You get up to 200 kS/s, 12-bit performance on 16 single-ended analog inputs. Depending on your type of hard drive, these devices can stream to disk at rates up to 200 kS/s.

These E Series devices feature digital triggering capability, as well as two 24-bit, 20 MHz counter/timers; and 8 digital I/O lines. The 6024E and 6025E also feature two 12-bit analog outputs. An additional 24 lines of 5 V/TTL I/O makes the 6025E family the best value of any PCI data acquisition device available.

For a more detailed hardware overview, refer to the E Series Multifunction I/O Overview on page 220.

Ordering Information

6023E Family

PCI-6023E and NI-DAQ for

Windows 2000/NT/9x.....777742-01

Mac OS777742-02

6024E Family

PCI-6024E and NI-DAQ for

Windows 2000/NT/9x.....777743-01

Mac OS777743-02

6025E Family

PCI-6025E and NI-DAQ for

Windows 2000/NT/9x.....777744-01

Mac OS777744-02

PXI-6025E.....777798-01

Includes NI-DAQ for Windows 2000/NT/9x on CD unless otherwise noted. See pages 192 and 210 for more details.

Example Configurations

Family	DAQ Board	Cable (page 296)	Accessory (page 292)
6023E	PCI-6023E	R6868 (182482-01)	CB-68LP (777145-01)
6024E	PCI-6024E	R6868 (182482-01)	CB-68LP (777145-01)
6025E	PCI-6025E	R1005050 (182762-01)	Two CB-50LPs (777101-01)
	PXI-6025E	R1005050 (182762-01)	Two CB-50LPs (777101-01)

For more detailed cable and accessory options, refer to page 286-299.

Data Acquisition

Low-Cost E Series Multifunction I/O – 200 kS/s, 12-Bit, 16 Analog Inputs

Nominal Range (V)	Absolute Accuracy							Relative Accuracy		
	% of Reading			Offset (mV)	Noise + Quantization (mV)		Temp Drift (%/°C)	Resolution (mV)		
	24 Hrs	90 Days	1 Year		Single Pt.	Averaged		Single Pt.	Averaged	
±10	0.072%	0.074%	0.076%	6.385	3.906	0.975	0.0010	5.892	1.284	
±5	0.027%	0.029%	0.031%	3.203	1.953	0.488	0.0005	2.946	0.642	
±0.5	0.072%	0.074%	0.076%	0.340	0.195	0.049	0.0010	0.295	0.064	
±0.05	0.072%	0.074%	0.076%	0.054	0.063	0.006	0.0010	0.073	0.008	

Note: Accuracies are valid for measurements following an internal E Series calibration. Averaged numbers assume dithering and averaging of 100 single-channel readings. Measurement accuracies are listed for operational temperatures within ±1 °C of internal calibration temperature and ±10 °C of external or factory-calibration temperature. One year calibration interval recommended. See page 300 for example accuracy calculations.

Table 2. 6023E/6024E/6025E Families Analog Input Accuracy Specifications

Nominal Range (V)	Absolute Accuracy				
	% of Reading			Offset (mV)	Temp Drift (%/°C)
	24 Hrs	90 Days	1 Year		
±10	0.018%	0.020%	0.022%	5.93	0.0005

Note: Temp Drift applies only if ambient is greater than ±10 °C of previous external calibration. See page 300 for example calculations.

Table 3. 6024E and 6025E Families Analog Output Accuracy Specifications



Refer to page 304 for more detailed specifications.

Product	Analog Input			Analog Output			Available DMA Channels	PCI Bus Master
	Sample Rate	Polarity	Range Selections	Update Rate	Polarity	FIFO Size		
PCI-6023E/6024E/6025E	200 kS/s	Bipolar	20 V, 10 V, 1 V, 100 mV	Up to 10 kS/s ¹	Bipolar	–	1	✓
PCI-6040E	250 kS/s	Unipolar or Bipolar	20 V, 10 V, 5 V, 2 V, 1 V 500 mV, 200 mV, 100 mV	Up to 1 MS/s	Unipolar or Bipolar	512 Samples	3	✓
PCI-6070E	1.25 MS/s	Unipolar or Bipolar	20 V, 10 V, 5 V, 2 V, 1 V 500 mV, 200 mV, 100 mV	Up to 1 MS/s	Unipolar or Bipolar	2,048 Samples	3	✓

¹ 10 kS/s system dependent when using the single DMA channel for analog output. 1 kS/s system dependent when using the single DMA channel for either analog input or counter/timer operations.

Table 4. How To Choose between the PCI-6024E, PCI-6040E, and PCI-6070E Families This table highlights the differences between these three families of products. Use the table to determine which device has the features your application requires.

ACH8	34	68	ACH0
ACH1	33	67	AIGND
AIGND	32	66	ACH9
ACH10	31	65	ACH2
ACH3	30	64	AIGND
AIGND	29	63	ACH11
ACH4	28	62	AISENSE
AIGND	27	61	ACH12
ACH13	26	60	ACH5
ACH6	25	59	AIGND
AIGND	24	58	ACH14
ACH15	23	57	ACH7
DAC0OUT ¹	22	56	AIGND
DAC1OUT ¹	21	55	AOGND ¹
RESERVED	20	54	AOGND ¹
DIO4	19	53	DGND
DGND	18	52	DIO0
DIO1	17	51	DIO5
DIO6	16	50	DGND
DGND	15	49	DIO2
5 V	14	48	DIO7
DGND	13	47	DIO3
DGND	12	46	SCANCLK
PF10/TRIG1	11	45	EXTSTROBE*
PF11/TRIG2	10	44	DGND
DGND	9	43	PF12/CONVERT*
5 V	8	42	PF13/GPCTR1_SOURCE
DGND	7	41	PF14/GPCTR1_GATE
PF15/UPDATE*	6	40	GPCTR1_OUT
PF16/WFTRIG	5	39	DGND
DGND	4	38	PF17/STARTSCAN
PF19/GPCTRO_GATE	3	37	PF18/GPCTRO_SOURCE
GPCTRO_OUT	2	36	DGND
FREQ_OUT	1	35	DGND

¹Not Available on 6023E

Figure 1. 6023E and 6024E Families I/O Connector

AIGND	1	51	PC7
AIGND	2	52	GND
ACH0	3	53	PC6
ACH8	4	54	GND
ACH1	5	55	PC5
ACH9	6	56	GND
ACH2	7	57	PC4
ACH10	8	58	GND
ACH3	9	59	PC3
ACH11	10	60	GND
ACH4	11	61	PC2
ACH12	12	62	GND
ACH5	13	63	PC1
ACH13	14	64	GND
ACH6	15	65	PC0
ACH14	16	66	GND
ACH7	17	67	PB7
ACH15	18	68	GND
AISENSE	19	69	PB6
DAC0OUT	20	70	GND
DAC1OUT	21	71	PB5
RESERVED	22	72	GND
DGND	23	73	PB4
DGND	24	74	GND
DIO0	25	75	PB3
DIO4	26	76	GND
DIO1	27	77	PB2
DIO5	28	78	GND
DIO2	29	79	PB1
DIO6	30	80	GND
DIO3	31	81	PB0
DIO7	32	82	GND
DGND	33	83	PA7
+5 V	34	84	GND
+5 V	35	85	PA6
SCANCLK	36	86	GND
EXTSTROBE*	37	87	PA5
PF10/TRIG1	38	88	GND
PF11/TRIG2	39	89	PA4
PF12/CONVERT*	40	90	GND
PF13/GPCTR1_SOURCE	41	91	PA3
PF14/GPCTR1_GATE	42	92	GND
GPCTR1_OUT	43	93	PA2
PF15/UPDATE*	44	94	GND
PF16/WFTRIG	45	95	PA1
PF17/STARTSCAN	46	96	GND
GPCTRO_SOURCE	47	97	PA0
GPCTRO_GATE	48	98	GND
GPCTRO_OUT	49	99	+5 V
FREQ_OUT	50	100	GND

Figure 2. 6025E Family I/O Connector

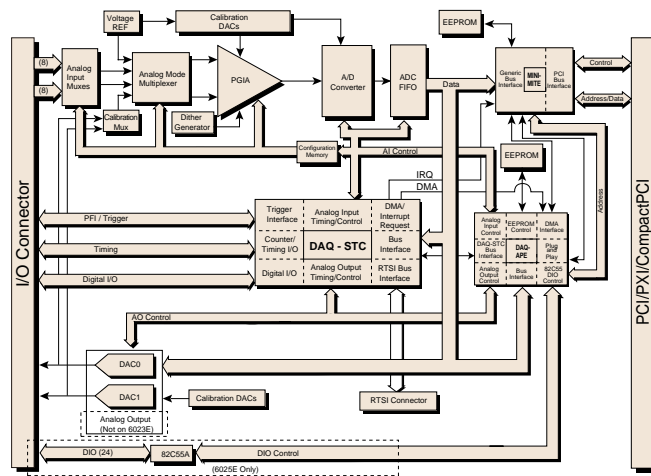


Figure 3. 6023E/6024E/6025E Families Hardware Block Diagram

Specifications

12-Bit E Series (6070E, 6060E, 6040E, and 6020E Families)

These specifications are typical for 25 °C unless otherwise noted.

Analog Input

Accuracy specifications See related product overview pages

Input Characteristics

Number of channels

6070E 6060E 604xE 602xE	16 single-ended or 8 differential (software selectable per channel)
6071E 6061E	64 single-ended or 32 differential (software selectable per channel)

Type of ADC Successive approximation

Resolution 12 bits, 1 in 4,096

Maximum sampling rate

607xE	1.25 MS/s
6060E	500 kS/s
604xE	500 kS/s single channel scanning 250 kS/s multichannel scanning
6061E	500 kS/s single channel scanning 333 kS/s multichannel
6023E 6024E 6025E	200 kS/s
6020E 6021E	100 kS/s

Streaming-to-disk rate (system dependent)¹

607xE	1.25 MS/s
606xE	500 kS/s
604xE	250 kS/s (except for DAQCard)
6023E 6024E 6025E	200 kS/s
6020E 6021E	100 kS/s ²

¹Streaming-to-disk rates do not apply to RT series devices

²DAQPad-6020E rates with SCSI or DMA-enabled EIDE

Input signal ranges

Device	Range (Software Selectable)	Input Range	
		Bipolar	Unipolar
607xE	20 V	±10 V	–
606xE	10 V	±5 V	0 to 10 V
604xE	5 V	±2.5 V	0 to 5 V
6020E	2 V	±1 V	0 to 2 V
6021E	1 V	±500 mV	0 to 1 V
	500 mV	±250 mV	0 to 500 mV
	200 mV	±100 mV	0 to 200 mV
	100 mV	±50 mV	0 to 100 mV
6023E	20 V	±10 V	–
6024E	10 V	±5 V	–
6025E	1 V	±500 mV	–
	100 mV	±50 mV	–

Input coupling DC

Maximum working voltage
(signal + common mode) Input should remain within
±11 V of ground

Overvoltage protection

Device	Powered On	Powered Off
607xE 606xE 604xE	±25 V	±15 V
6023E 6024E 6025E	±40 V	±25 V
6020E 6021E	±35 V	±25 V

Inputs protected

6070E 6060E 604xE 602xE	ACH<0..15>, AISENSE
6071E 6061E	ACH<0..63>, AISENSE, AISENSE2

FIFO buffer size

AT-MIO-16E-1	8,192 Samples
DAQPad-6020E	4,096 Samples
606xE DAQPad-6070E	2,048 Samples
6041E	1,024 Samples
PCI-MIO-16E-1 PXI-6070E 6071E, 6040E 602xE, except DAQPad	512 Samples

Data transfers

PCI, PXI, AT, VXI, DAQPad for IEEE 1394 DMA, interrupts, programmed I/O
DAQCard, DAQPad for USB Interrupts, programmed I/O

DMA modes

PCI, PXI, VXI, DAQPad for IEEE 1394 Scatter-gather (single-transfer, demand transfer)
AT Single transfer, demand transfer

Configuration memory size 512 words

Transfer Characteristics

Relative accuracy

Device	Typical Dithered	Maximum Undithered
607xE 606xE 604xE 6023E 6024E 6025E	±0.5 LSB	±1.5 LSB
6020E 6021E	±0.2 LSB	±1.5 LSB

DNL

Board	Typical	Maximum
607xE 606xE 604xE 6023E 6024E 6025E	±0.5 LSB	±1.0 LSB
6020E 6021E	±0.2 LSB	±1.0 LSB

No missing codes 12 bits, guaranteed

Amplifier Characteristics

Input Impedance

Device	Normal Powered On	Powered Off	Overload
6070E 606xE 6040E PCI-6071E PXI-6071E	100 GΩ in parallel with 100 pF	820 Ω	820 Ω
VXI-MIO-64E-1 6041E	100 GΩ in parallel with 100 pF	1 kΩ	1 kΩ
602xE	100 GΩ in parallel with 100 pF	4.7 kΩ	4.7 kΩ

Input bias current ±200 pA

Input offset current ±100 pA

CMRR, DC to 60 Hz

Device	Range	CMRR
607xE	20 V	95 dB
606xE	10 V	100 dB
	100 mV to 5 V	106 dB
604xE	10 to 20 V	85 dB
	5 V	95 dB
	100 mV to 2 V	100 dB
6023E	10 to 20 V	85 dB
6024E	100 mV to 1 V	90 dB
6025E		
6020E	100 mV to 20 V	90 dB
6021E		

Specifications

12-Bit E Series (continued)

Dynamic Characteristics

Bandwidth

Device	Small Signal (-3 dB)	Large Signal (1% THD)
607xE	1.6 MHz	1 MHz
606xE	1 MHz	300 kHz
6041E	800 kHz	400 kHz
6040E	600 kHz	350 kHz
6023E	500 kHz	225 kHz
6024E		
6025E		
6021E	150 kHz	120 kHz

Settling time to full-scale step

Device	Range	Accuracy		
		±0.012% (±0.5 LSB)	±0.024% (±1 LSB)	±0.098% (±4 LSB)
6070E	20 V	2 µs typical 3 µs max	1.5 µs typical 2 µs max	1.5 µs typical 2 µs max
	10 V	2 µs typical 3 µs max	1.5 µs typical 2 µs max	1.3 µs typical 1.5 µs max
	200 mV to 5 V	2 µs typical 3 µs max	1.5 µs typical 2 µs max	0.9 µs typical 1 µs max
	100 mV	2 µs typical 3 µs max	1.5 µs typical 2 µs max	1 µs typical 1.5 µs max
PCI-6071E PXI-6071E	20 V	3 µs typical 5 µs max	1.9 µs typical 2.5 µs max	1.9 µs typical 2 µs max
	10 V	3 µs typical 5 µs max	1.9 µs typical 2.5 µs max	1.2 µs typical 1.5 µs max
	200 mV to 5 V	3 µs typical 5 µs max	1.9 µs typical 2.5 µs max	1.2 µs typical 1.3 µs max
	100 mV	3 µs typical 5 µs max	1.9 µs typical 2.5 µs max	1.2 µs typical 1.5 µs max
6060E	All	2 µs typical 4 µs max	1.9 µs typical 2 µs max	1.8 µs typical 2 µs max
6061E VXI-MIO-64E-1	All	3 µs typical 5 µs max	2 µs typical 3 µs max	1.8 µs typical 2 µs max
604xE	All	4 µs typical 8 µs max	4 µs max	4 µs max
6023E 6024E 6025E	All	5 µs typical	5 µs max	5 µs max
6020E 6021E	All	10 µs max	10 µs max	10 µs max

System noise (LSB_{rms}, not including quantization)

Device	Range	Dither Off	Dither On
6070E	1 V to 20 V	0.25	0.5
PCI-6071E	500 mV	0.4	0.6
PXI-6071E	200 mV	0.5	0.7
	100 mV	0.8	0.9
VXI-MIO-64E-1	500 mV to 20 V	0.15	0.5
606xE	200 mV	0.3	0.6
	100 mV	0.5	0.7
604xE	1 V to 20 V	0.2	0.5
	500 mV	0.25	0.5
	200 mV	0.5	0.7
	100 mV	0.9	1.0
6023E	1 V to 20 V	0.1	0.6
6024E	100 mV	0.7	0.8
6025E			
6020E	1 V to 20 V	0.07	0.5
6021E	500 mV	0.12	0.5
	200 mV	0.25	0.6
	100 mV	0.5	0.7

Crosstalk, DC to 100 KHz

Device	Adjacent Channels	All Other Channels
607xE, 606xE, 604xE	-75 dB	-90 dB
602xE	-60 dB	-80 dB

Analog Output Output Characteristics

Number of channels

607xE 606xE 6040E 6020E 6021E 6024E 6025E	2 voltage outputs
6041E 6023E	None

Resolution 12 bits, 1 in 4096

Maximum update rate

Device	Waveform Generation			
	FIFO Mode		Non-FIFO Mode	
	Internally Timed	Externally Timed	1 Channel	2 Channels
607xE 606xE 6040E	1 MS/s	950 kS/s	800 kS/s, system dependent	400 kS/s, system dependent
6023E 6024E 6025E	N/A	N/A	10 kS/s with DMA 1 kS/s with interrupts system dependent	10 kS/s with DMA 1 kS/s with interrupts system dependent
6020E; except DAQPad-6020E	N/A	N/A	100 kS/s, system dependent	100 kS/s, system dependent
DAQPad-6020E	N/A	N/A	20 S/s, system dependent	20 S/s, system dependent

Type of DAC Double buffered, multiplying

FIFO buffer size

607xE 606xE	2,048 samples
6040E	512 samples
602xE	None

Data transfers

PCI, PXI, AT, VXI, DAQPad for IEEE-1394 DMA, interrupts, programmed I/O
DAQPad for USB, DAQCard Interrupts, programmed I/O

DMA modes

PCI, PXI, VXI, DAQPad Scatter-gather (single transfer,
demand transfer)
AT Single transfer, demand transfer

Transfer Characteristics

Relative accuracy

After calibration ±0.3 LSB typical, ±0.5 LSB max
Before calibration ±4 LSB max

DNL

After calibration ±0.3 LSB typical, ±1.0 LSB max
Before calibration ±3 LSB max

Monotonicity 12 bits, guaranteed after calibration

Gain error (relative to external reference) 0% to +0.67% of output max,
not adjustable

Voltage Output

Ranges

607xE 606xE 6040E 6020E 6021E	±10 V, 0 to 10 V, ±EXTREF, 0 to EXTREF; software selectable
6023E 6024E 6025E	±10 V

Output coupling DC

Output impedance 0.1 Ω max

Current drive ±5 mA max

Protection Short-circuit to ground

Power-on state 0 V (±200 mV)

Specifications

12-Bit E Series (continued)

External reference input (not available on 6024E or 6025E)

Range ±11 V

Overvoltage protection

607xE	±25 V powered on, ±15 V powered off
606xE	
604xE	
602xE	±35 V powered on, ±25 V powered off

Input impedance 10 kΩ

Bandwidth (-3 dB)

607xE	1 MHz
606xE	
604xE	
602xE	300 kHz

Dynamic Characteristics

Settling time and slew rate

Device	Settling Time for Full-Scale Step	Slew Rate
607xE	3 μs to ±0.5 LSB accuracy	20 V/μs
606xE		
6040E		
602xE	10 μs to ±0.5 LSB accuracy	10 V/μs

Noise 200 μV_{rms}, DC to 1 MHz

Glitch energy (at mid-scale transition)

Magnitude

Device	Reglitching Disabled	Reglitching Enabled
DAQPad-6070E	±20 mV	±4 mV
PCI-MIO-16E-1		
PCI-6071E		
PXI-6070E		
PXI-6071E		
AT-MIO-16E-1	±200 mV	±30 mV
606xE		
604xE		
VXI-MIO-64E-1	±70 mV	±40 mV
6023E	±12 mV	N/A
6024E		
6025E		
6020E	±100 mV	N/A
6021E		

Duration

607xE	1.5 μs
606xE	
604xE	
6023E	2 μs
6024E	
6025E	
6020E	3 μs
6021E	

Stability

Gain temperature coefficient

External reference ±25 ppm/°C

Digital I/O

6021E	32 input/output
6025E	
All others	8 input/output

Number of channels

Compatibility 5 V/TTL

Power-on state Input; high impedance

Digital logic levels

DIO<0..7> on all boards

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (<i>I</i> _{out} = 24 mA)	–	0.4 V
Output high voltage (<i>I</i> _{out} = 13 mA)	4.35 V	–

PA<0..7>, PB<0..7>, PC<0..7> on remaining 24 lines of 6021E and 6025E

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (<i>I</i> _{out} = 2.5 mA)	–	0.4 V
Output high voltage (<i>I</i> _{out} = 2.5 mA)	3.9 V	–

Data transfers

6021E	Interrupts, programmed I/O
6025E	
All others	Programmed I/O

Handshaking (6021E and 6025E only)

Direction Input or output

Modes 2-wire

Transfer rate (1 word = 8 bits)

Maximum with NI-DAQ, system dependent

DAQPad-6070E	5 kwords/s
All others	50 kwords/s

Constant sustainable rate 1 to 10 kwords/s, typical

Timing I/O

General-purpose Up/Down Counter/Timers

Number of channels 2

Resolution 24 bits

Compatibility 5 V/TTL

Digital logic levels

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (<i>I</i> _{out} = 5 mA)	–	0.4 V
Output high voltage (<i>I</i> _{out} = 3.5 mA)	4.35 V	–

Base clocks available 20 MHz and 100 kHz

Base clock accuracy ±0.01%

Maximum source frequency 20 MHz

External source selections¹ PFI0..PFI9, RTSIO..RTSI3/6, Analog trigger; software selectable

External gate selections¹ PFI0..PFI9, RTSIO..RTSI3/6, Analog trigger; software selectable

Minimum source pulse duration 10 ns

Minimum gate pulse duration 10 ns, edge-detect mode

Data transfers

PCI, PXI, AT, VXI, DAQPad for IEEE 1394 DMA, interrupts, programmed I/O

DAQCard, DAQPad for USB Interrupts, programmed I/O

DMA modes

PCI, PXI, VXI, DAQPad for IEEE 1394 Scatter-gather (single transfer, demand transfer)

AT Single transfer, demand transfer

Frequency Scaler

Number of channels 1

Resolution 4 bits

Compatibility 5 V/TTL

Digital logic levels

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (<i>I</i> _{out} = 5 mA)	–	0.4 V
Output high voltage (<i>I</i> _{out} = 3.5 mA)	4.35 V	–

Base clocks available 10 MHz, 100 kHz

Base clock accuracy ±0.01%

Data transfers Programmed I/O

Triggers

Analog Triggers

Number of triggers

607xE	1
606xE	
604xE	
602xE	None

Specifications

12-Bit E Series (continued)

Purpose
 Analog input Start and stop trigger, gate, clock
 Analog output Start trigger, gate, clock
 General-purpose counter/timers Source, gate

Device	Source
6070E 6060E 604xE 602xE	ACH<0..15>, PFI0/TRIG1
6071E 6061E	ACH<0..63>, PFI0/TRIG1

Level
 Internal source, ACH<0..15/63> \pm Full-scale
 External source, PFI0/TRIG1 \pm 10 V
 Slope Positive or negative; software selectable
 Resolution 8 bits, 1 in 256
 Bandwidth (-3 dB)

Device	Internal Source	External Source
607xE	2 MHz	7 MHz
606xE	1 MHz	7 MHz
604xE	2 MHz	3 MHz

Hysteresis Programmable
 Accuracy \pm 5% of full-scale range max

Digital Triggers (all boards)

Number of triggers 2
 Purpose
 Analog input Start and stop trigger, gate, clock
 Analog output Start trigger, gate, clock
 General-purpose counter/timers Source, gate
 Source¹ PFI0..PFI9, RTSI0..RTSI3/6
 Slope Positive or negative; software selectable
 Compatibility 5 V/TTL
 Response Rising or falling edge
 Pulse width 10 ns minimum
 External input for digital or analog trigger (PFI0/TRIG1)
 Impedance 10 k Ω
 Coupling DC
 Protection
 Digital trigger -0.5 to Vcc + 0.5 V
 Analog trigger
 On/Off/Disabled \pm 35 V

Calibration

Recommended warm-up time 15 minutes; 30 minutes for DAQCard and DAQPad
 Calibration interval 1 year
 Onboard calibration reference
 DC Level 5.000 V (\pm 3.5 mV); (\pm 0.5 mV for VXI) over full operating temperatures, actual value stored in EEPROM
 Temperature coefficient \pm 5 ppm/ $^{\circ}$ C max; (\pm 0.6 ppm/ $^{\circ}$ C max for VXI)
 Long-term stability \pm 15 ppm/ \sqrt{t} 000 h; (\pm 6 ppm/ \sqrt{t} 000 h for VXI)

RTSI (PCI, DAQPad-6070E for IEEE 1394, and ISA only)

Trigger lines
 PCI, ISA 7
 DAQPad for IEEE 1394 4

PXI Trigger Bus (PXI only)

Trigger lines 6
 Star trigger 1

VXI Trigger Bus (VXI only)

Trigger lines 5 (5 V/TTL), 2 ECL

Bus Interface

PCI, PXI, DAQPad for IEEE 1394 Master, slave
 AT, DAQCard, DAQPad for USB, VXI Slave

Power Requirements^{1,3}

Device	+5 VDC (\pm 5%)*	Power Available at I/O Connector
607xE	1.1 A	+4.65 to +5.25 VDC, 1 A
606xE 6040E	1.0 A	+4.65 to +5.25 VDC, 1 A
602xE, (except DAQPad)	0.7 A	+4.65 to +5.25 VDC, 1 A
DAQCard-AI-16E-4	280 mA typical 400 mA maximum	+4.65 to +5.25 VDC, 250 mA

*Excludes power consumed through I/O connector.

Device	Power	Power Available at I/O Connector
DAQPad-6020E	15 W ² , +9 to +30 VDC	+4.65 to +5.25 VDC, 1 A
DAQPad-6070E	17 W ² , +9 to +25 VDC	+4.65 to +5.25 VDC, 1 A

Discharge time with BP-1 battery pack

IEEE 1394 DAQCards 2.5 hours, typical
 USB DAQCards 3 hours, typical

Physical²

Dimensions (not including connectors)²

PCF 17.5 by 9.9 cm (6.9 by 3.9 in.)
 PXI 16.0 by 10.0 cm (6.3 by 3.9 in.)
 AT (long) 33.8 by 9.9 cm (13.3 by 3.9 in.)
 AT (short) 17.5 by 9.9 cm (6.9 by 4.2 in.)
 DAQPad (30 cm enclosure) 25.4 by 30.5 by 4.6 cm (10 by 12 by 1.8 in.)
 DAQPad (15 cm enclosure) 14.6 by 21.3 by 3.8 cm (5.8 by 8.4 by 1.5 in.)
 DAQCard Type II PC Card

I/O connector²

6070E 6060E 6040E 6020E 6023E 6024E	68-pin male 0.050 D-type
6071E 6061E 6021E 6025E	100-pin female 0.050 D-type
DAQCard-AI-16E-4	68-pin female PCMCIA

Environment

Operating temperature 0 to 55 $^{\circ}$ C; DAQCard case temperature should not exceed 55 $^{\circ}$ C while in PCMCIA slot; 0 to 50 $^{\circ}$ C for DAQCards
 Storage temperature -20 to 70 $^{\circ}$ C
 Relative humidity 10 to 90%, noncondensing

Certifications and Compliances

CE Mark Compliance CE

¹ Refer to RTSI specifications for available RTSI trigger lines.
² For VXI power requirements, dimensions, and I/O connections, refer to the *VXI Solutions Product Guide*.
³ For RT Series devices power requirements and dimensions, refer to page 247.